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				Application Number	10/765 292		
INFOR	MATION	A DIZ	CLOSURE	Filing Date	27 January 2004 (herewith)		
STATE	EMENT L	3Y AF	PPLICANT	First Named Inventor	Tzu-Hsuan Hsu et al.		
				Group Art Unit	2827		
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heet	1	of	2	Attorney Docket Number	MXIC 1561-1		

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Examiner Initials	Cite No.1	Mimher	Code ²	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Signature	M. TRAN	Date Considered	3/18/05

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST, 16 if possible. Applicant is to place a check mark here if English language Translation is attached.



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				Application Number	10/765292		
INF	DRMATIC)N D	ISCLOSURE	Filing Date	27 January 2004 (herewith)		
STA	TEMENT	BY	APPLICANT	First Named Inventor	Tzu-Hsuan Hsu et al.		
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Sheet	2	of	2	Attorney Docket Number	MXIC 1561-1		

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Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T2
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